DS90CF384AQ +3.3V LVDS Receiver 24-Bit Flat Panel Display (FPD) Link - 65 MHz

Check for Samples: DS90CF384AQ

FEATURES

- **Automotive Grade Device, AEC-Q100 Grade 3 Qualified**
- **Operating Temperature Range: –40°C to +85°C**
- **20 to 65 MHz Shift Clock Support**
- **50% Duty Cycle on Receiver Output Clock**
- **Best–in–Class Set & Hold Times on RxOUTPUTs**
- **Rx Power Consumption <142 mW (typ) @65MHz Grayscale**
- **Rx Power-down Mode <200µW (max)**
- **ESD Rating >7 kV (HBM), >700V (EIAJ)**
- **Supports VGA, SVGA, XGA and Dual Pixel SXGA.**
- **PLL Requires No External Components**
- **Compatible with TIA/EIA-644 LVDS Standard**
- **Low Profile 56-Lead TSSOP Package**

DESCRIPTION

The DS90CF384AQ receiver converts the four LVDS data streams at up to 1.8 Gbps throughput (227 Megabytes/sec bandwidth) back into parallel 28 bits of LVCMOS/LVTTL data. In a Display application, the 28 bits include: 24 bits of RGB data and up to 4 bits of video control (Hsync, Vsync, DE and CNTL).

The DS90CF384AQ device is enhanced over prior generation FPD-Link receivers, provides a wider data valid time on the receiver output and is offered as an AEC-Q100 grade 3 device.

FPD-Link is an ideal means to solve EMI and cable size problems associated with wide, high speed LVCMOS/LVTTL interfaces.

Block Diagram

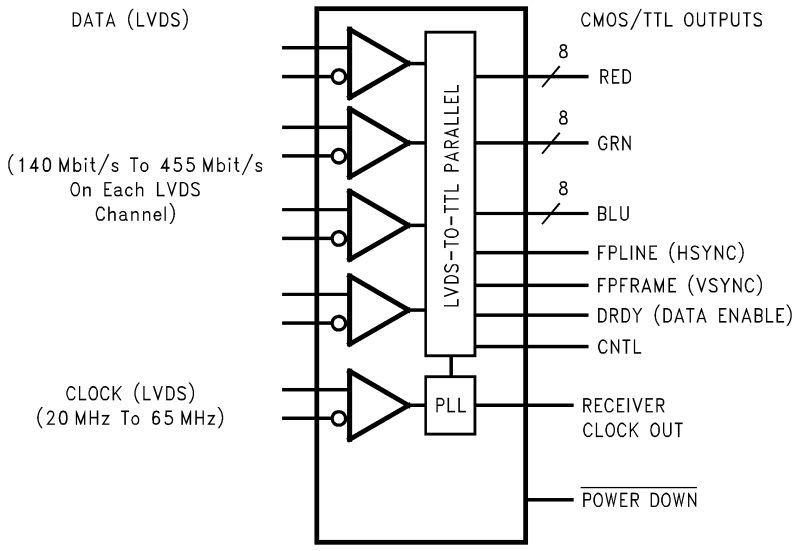


Figure 1. DS90CF384AQ Block Diagram

This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

Absolute Maximum Ratings(1)(2)

Supply Voltage (V_{CC})		−0.3V to +4V
LVCMOS/LVTTL Input Voltage		−0.3V to (V_{CC} + 0.3V)
LVCMOS/LVTTL Output Voltage		−0.3V to (V_{CC} + 0.3V)
LVDS Receiver Input Voltage		−0.3V to (V_{CC} + 0.3V)
Junction Temperature		+150°C
Storage Temperature		−65°C to +150°C
For soldering specifications: see http://www.ti.com/lit/SNOA549		
Maximum Package Power Dissipation Capacity @ 25°C		
DGG Package:		1.61 W
DGG Package Derating:		12.4 mW/°C above +25°C
ESD Rating	(HBM, 1.5 kΩ, 100 pF)	> 7 kV
	(EIAJ, 0Ω, 200 pF)	> 700V

(1) If Military/Aerospace specified devices are required, please contact the TI Sales Office/ Distributors for availability and specifications.
(2) "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be ensured. They are not meant to imply that the device should be operated at these limits. The "Electrical Characteristics" specify conditions for device operation.

Recommended OperatingConditions

	Min	Nom	Max	Units
Supply Voltage (V_{CC})	3.0	3.3	3.6	V
Operating Free Air				
Temperature (T_A)	−40	+25	+85	°C
Receiver Input Range	0		2.4	V
Supply Noise Voltage (V_{CC})			100	mV_{PP}

Electrical Characteristics

Over recommended operating supply and temperature ranges unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ(1)	Max	Units
LVCMOS/LVTTL DC SPECIFICATIONS (For Power Down Pin)						
V_{IH}	High Level Input Voltage		2.0		V_{CC}	V
V_{IL}	Low Level Input Voltage		GND		0.8	V
V_{CL}	Input Clamp Voltage	I_{CL} = −18 mA		−0.79	−1.5	V
I_{IN}	Input Current	V_{IN} = 0.4V, 2.5V or V_{CC}		+1.8	+10	µA
		V_{IN} = GND	−10	0		µA
LVCMOS/LVTTL DC SPECIFICATIONS						
V_{OH}	High Level Output Voltage	I_{OH} = −0.4 mA	2.7	3.3		V
V_{OL}	Low Level Output Voltage	I_{OL} = 2 mA		0.06	0.3	V
I_{OS}	Output Short Circuit Current	V_{OUT} = 0V		−60	−120	mA
LVDS RECEIVER DC SPECIFICATIONS						
V_{TH}	Differential Input High Threshold	V_{CM} = +1.2V			+100	mV
V_{TL}	Differential Input Low Threshold		−100			mV
I_{IN}	Input Current	V_{IN} = +2.4V, V_{CC} = 3.6V			±10	µA
		V_{IN} = 0V, V_{CC} = 3.6V			±10	µA

(1) Typical values are given for V_{CC} = 3.3V and T_A = +25C.

Electrical Characteristics (continued)

Over recommended operating supply and temperature ranges unless otherwise specified.

Symbol	Parameter	Conditions		Min	Typ[1]	Max	Units
RECEIVER SUPPLY CURRENT[2]							
ICCRW	Receiver Supply Current Worst Case	C_L = 8 pF, Worst Case Pattern (Figure 2 and Figure 4)	f = 32.5 MHz		49	65	mA
			f = 37.5 MHz		53	70	mA
			f = 65 MHz		81	105	mA
ICCRG	Receiver Supply Current, 16 Grayscale	C_L = 8 pF, 16 Grayscale Pattern (Figure 3 and Figure 4)	f = 32.5 MHz		28		mA
			f = 37.5 MHz		30		mA
			f = 65 MHz		43		mA
ICCRZ	Receiver Supply Current Power Down	$\overline{\text{Power Down}}$ = Low, Receiver Outputs Stay Low during Power Down Mode			10	55	µA

(2) Current into device pins is defined as positive. Current out of device pins is defined as negative. Voltages are referenced to ground unless otherwise specified (except V_{OD} and ΔV_{OD}).

Receiver Switching Characteristics

Over recommended operating supply and temperature ranges unless otherwise specified

Symbol	Parameter		Min	Typ	Max	Units
CLHT	CMOS/TTL Low-to-High Transition Time (Figure 4)			2	5	ns
CHLT	CMOS/TTL High-to-Low Transition Time (Figure 4)			1.8	5	ns
RSPos0	Receiver Input Strobe Position for Bit 0 (Figure 10)	f = 25 MHz	1.20	1.96	2.82	ns
RSPos1	Receiver Input Strobe Position for Bit 1		6.91	7.67	8.53	ns
RSPos2	Receiver Input Strobe Position for Bit 2		12.62	13.38	14.24	ns
RSPos3	Receiver Input Strobe Position for Bit 3		18.33	19.09	19.95	ns
RSPos4	Receiver Input Strobe Position for Bit 4		24.04	24.80	25.66	ns
RSPos5	Receiver Input Strobe Position for Bit 5		29.75	30.51	31.37	ns
RSPos6	Receiver Input Strobe Position for Bit 6		35.46	36.22	37.08	ns
RSPos0	Receiver Input Strobe Position for Bit 0 (Figure 10)	f = 65 MHz	0.7	1.1	1.4	ns
RSPos1	Receiver Input Strobe Position for Bit 1		2.9	3.3	3.6	ns
RSPos2	Receiver Input Strobe Position for Bit 2		5.1	5.5	5.8	ns
RSPos3	Receiver Input Strobe Position for Bit 3		7.3	7.7	8.0	ns
RSPos4	Receiver Input Strobe Position for Bit 4		9.5	9.9	10.2	ns
RSPos5	Receiver Input Strobe Position for Bit 5		11.7	12.1	12.4	ns
RSPos6	Receiver Input Strobe Position for Bit 6		13.9	14.3	14.6	ns
RSKM	RxIN Skew Margin[1](Figure 11)	f = 25 MHz	750			ps
		f = 65 MHz	500			ps
RCOP	RxCLK OUT Period (Figure 5)		15	T	50	ns
RCOH	RxCLK OUT High Time (Figure 5)	f = 65 MHz	5.0	7.6	9.0	ns
RCOL	RxCLK OUT Low Time (Figure 5)		5.0	6.3	9.0	ns
RSRC	RxOUT Setup to RxCLK OUT (Figure 5)		4.5	7.3		ns
RHRC	RxOUT Hold to RxCLK OUT (Figure 5)		4.0	6.3		ns
RCCD	RxCLK IN to RxCLK OUT Delay @ 25°C, V_{CC} = 3.3V (Figure 6)		3.5	5.0	7.5	ns
RPLLS	Receiver Phase Lock Loop Set (Figure 7)				10	ms
RPDD	Receiver Power Down Delay (Figure 9)				1	µs

(1) Receiver Skew Margin is defined as the valid data sampling region at the receiver inputs. This margin takes into account the DS90C383B transmitter pulse positions (min and max) and the receiver input setup and hold time (internal data sampling window - RSPos). The RSKM will change when different transmitters are used. This margin allows for LVDS interconnect skew, inter-symbol interference (both dependent on type/length of cable), and clock jitter (less than 250 ps).

AC Timing Diagrams

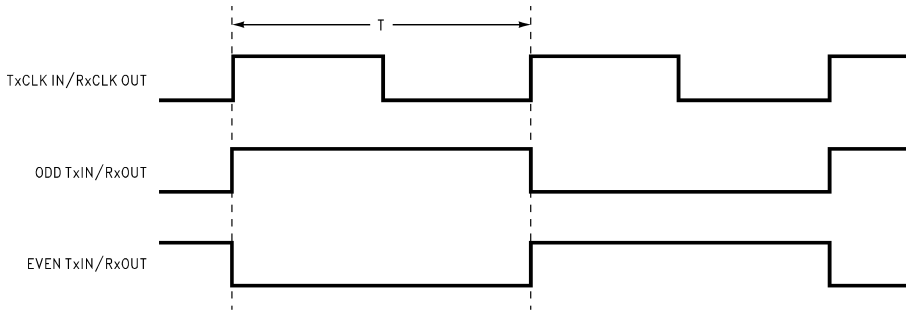
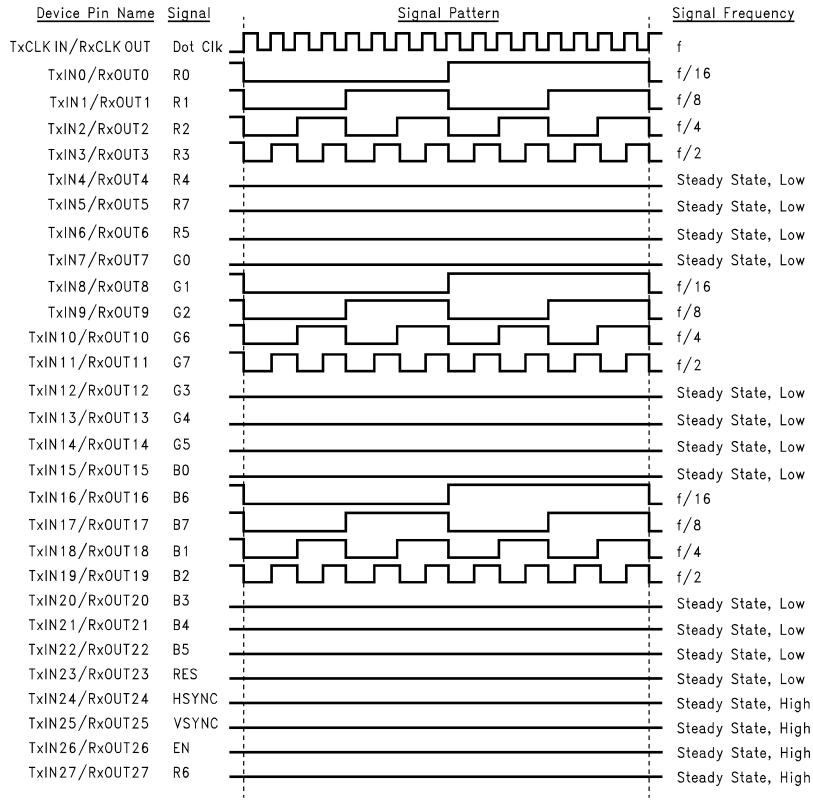


Figure 2. "Worst Case" Test Pattern



The worst case test pattern produces a maximum toggling of digital circuits, LVDS I/O and CMOS/TTL I/O.

The 16 grayscale test pattern tests device power consumption for a "typical" LCD display pattern. The test pattern approximates signal switching needed to produce groups of 16 vertical stripes across the display.

Figure 2 and Figure 3 show a falling edge data strobe (TxCLK IN / RxCLK OUT).

Recommended pin to signal mapping. Application may choose to define differently, check compatibility with source.

Figure 3. "16 Grayscale" Test Pattern

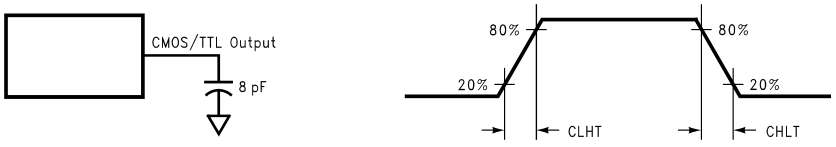


Figure 4. Receiver CMOS/TTL Output Load and Transition Times

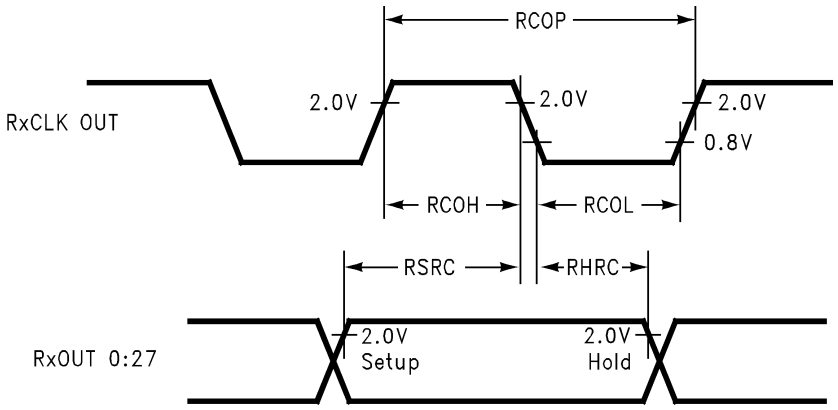


Figure 5. Receiver Output Setup/Hold and High/Low Times

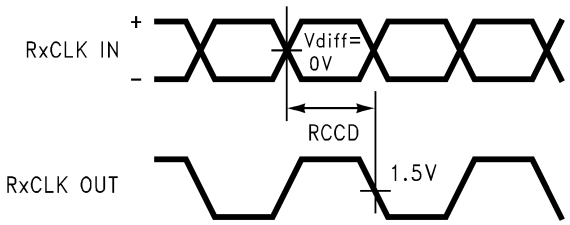


Figure 6. Receiver Clock In to Clock Out Delay

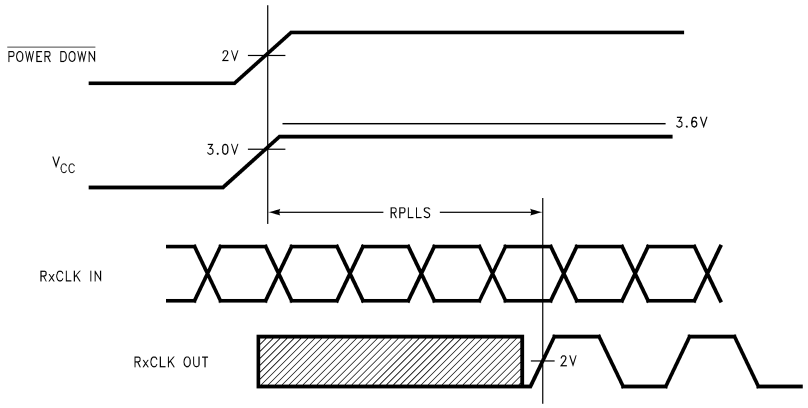


Figure 7. Receiver Phase Lock Loop Set Time

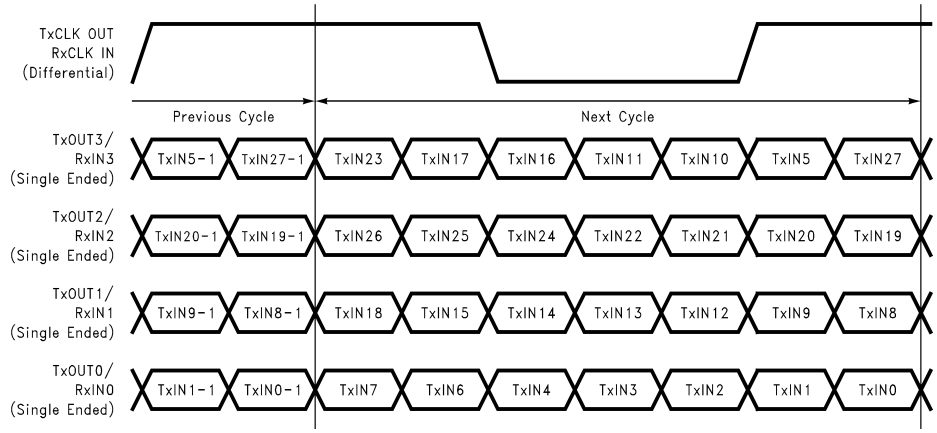


Figure 8. 28 Parallel TTL Data Inputs/Outputs Mapped to LVDS Bits (TxINn / RxOUTn)

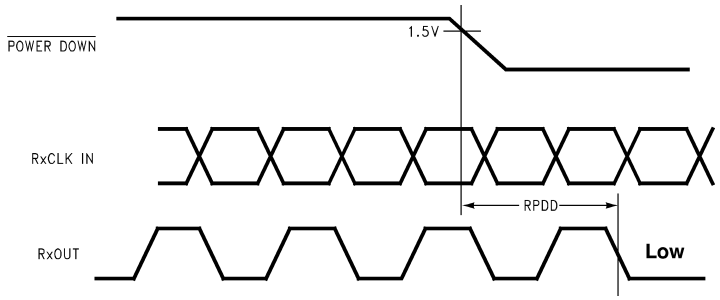


Figure 9. Receiver Power Down Delay

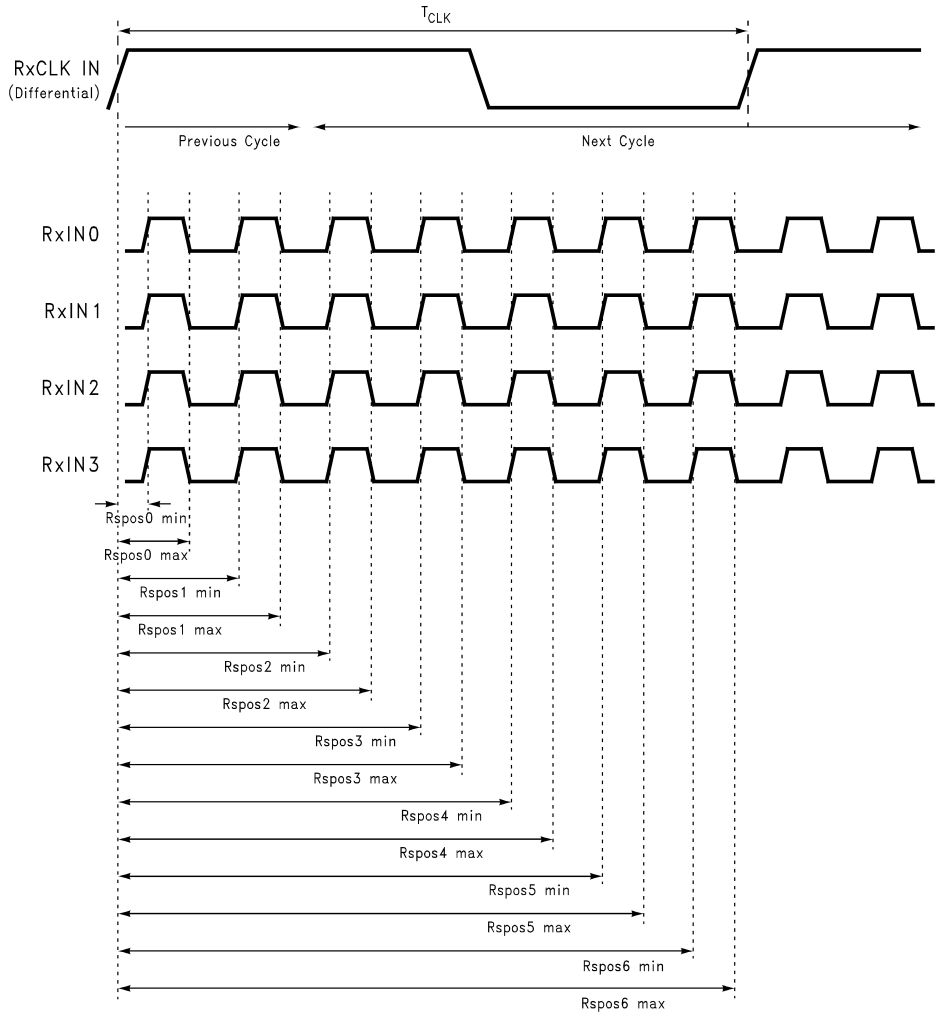
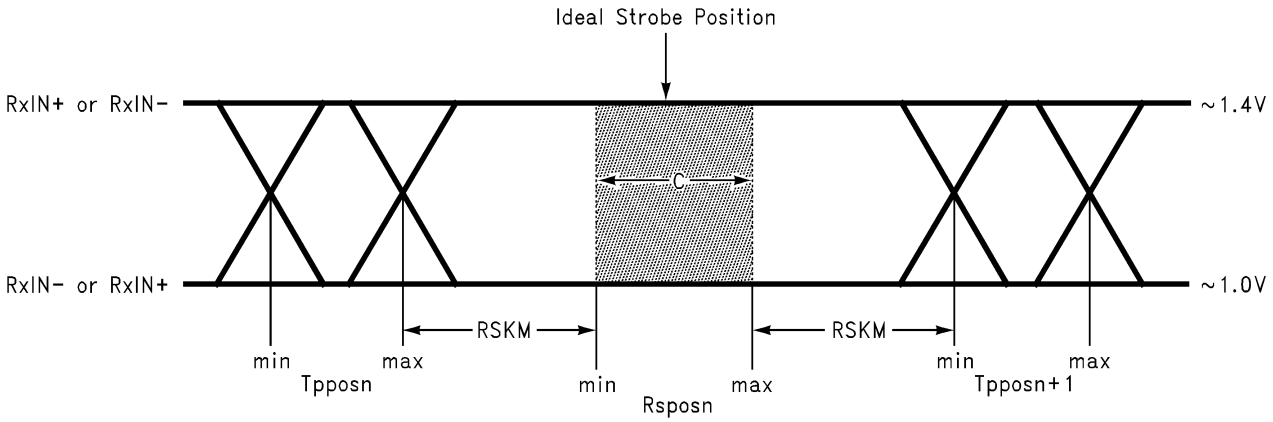


Figure 10. Receiver LVDS Input Strobe Position



C—Setup and Hold Time (Internal data sampling window) defined by Rspos (receiver input strobe position) min and max
Tppos—Transmitter output pulse position (min and max)
RSKM = Cable Skew (type, length) + Source Clock Jitter (cycle to cycle) + ISI (Inter-symbol interference)
Cable Skew—typically 10 ps–40 ps per foot, media dependent

Cycle-to-cycle jitter is less than 250 ps at 65 MHz.

ISI is dependent on interconnect length; may be zero.

Figure 11. Receiver LVDS Input Skew Margin

DS90CF384AQ Pin Descriptions — 56L TSSOP Package

Pin Name	I/O	No.	Description
RxIN+	I	4	Positive LVDS differential data inputs.
RxIN−	I	4	Negative LVDS differential data inputs.
RxOUT	O	28	TTL level data outputs. This includes: 8 Red, 8 Green, 8 Blue, and 3 control lines—FPLINE, FPFRAME, DRDY (also referred to as HSYNC, VSYNC, Data Enable).
RxCLK IN+	I	1	Positive LVDS differential clock input.
RxCLK IN−	I	1	Negative LVDS differential clock input.
RxCLK OUT	O	1	TTL level clock output. The falling edge acts as data strobe.
$\overline{\text{PWR DOWN}}$	I	1	TTL level input. When asserted (low input) the receiver outputs are low.
V_{CC}	I	4	Power supply pins for TTL outputs.
GND	I	5	Ground pins for TTL outputs.
PLL V_{CC}	I	1	Power supply for PLL.
PLL GND	I	2	Ground pin for PLL.
LVDS V_{CC}	I	1	Power supply pin for LVDS inputs.
LVDS GND	I	3	Ground pins for LVDS inputs.

Pin Diagram for TSSOP Package

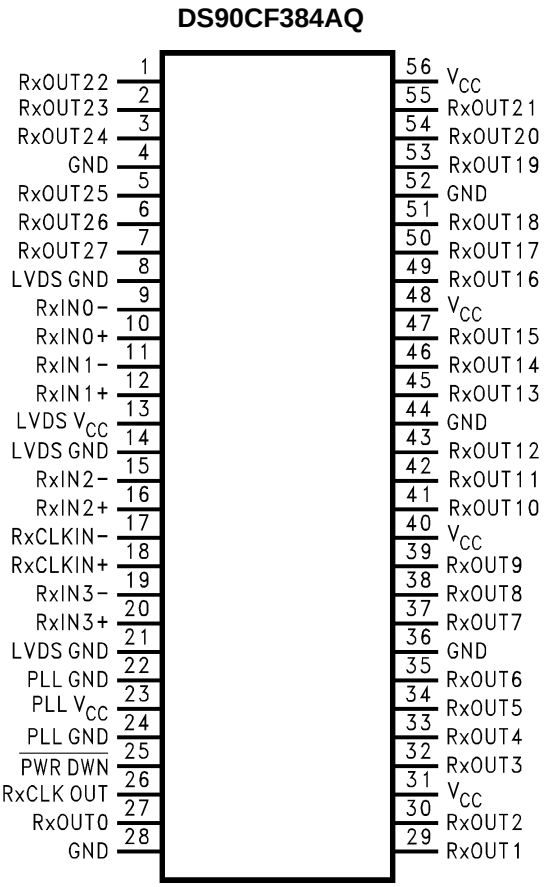


Figure 12. 56-Lead TSSOP (DGG Package)

REVISION HISTORY

Changes from Original (April 2013) to Revision A	Page
• Changed layout of National Data Sheet to TI format	9

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
DS90CF384AQMT/NOPB	ACTIVE	TSSOP	DGG	56	34	RoHS & Green	SN	Level-2-260C-1 YEAR	-40 to 85	DS90CF384AQ MT	Samples
DS90CF384AQMTX/NOPB	ACTIVE	TSSOP	DGG	56	1000	RoHS & Green	SN	Level-2-260C-1 YEAR	-40 to 85	DS90CF384AQ MT	Samples

(1) The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".
RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.
Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

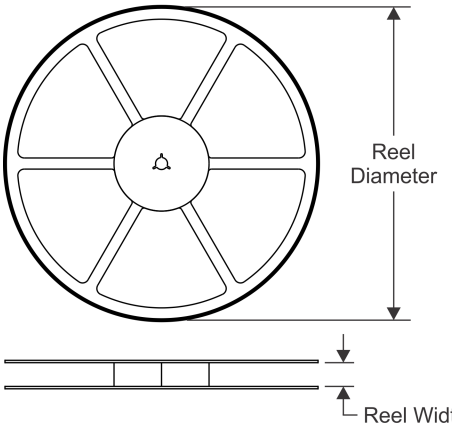
(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

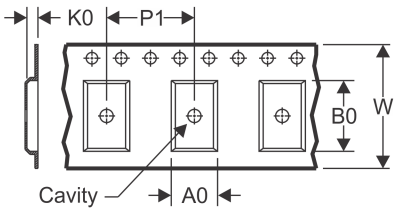
(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

TAPE AND REEL INFORMATION

REEL DIMENSIONS

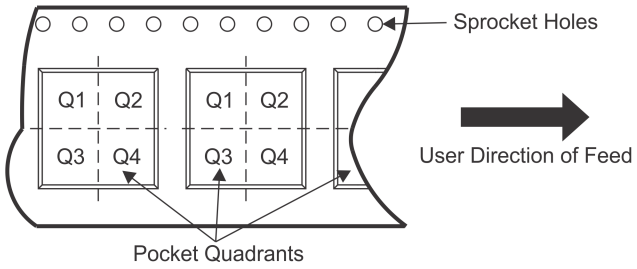


TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

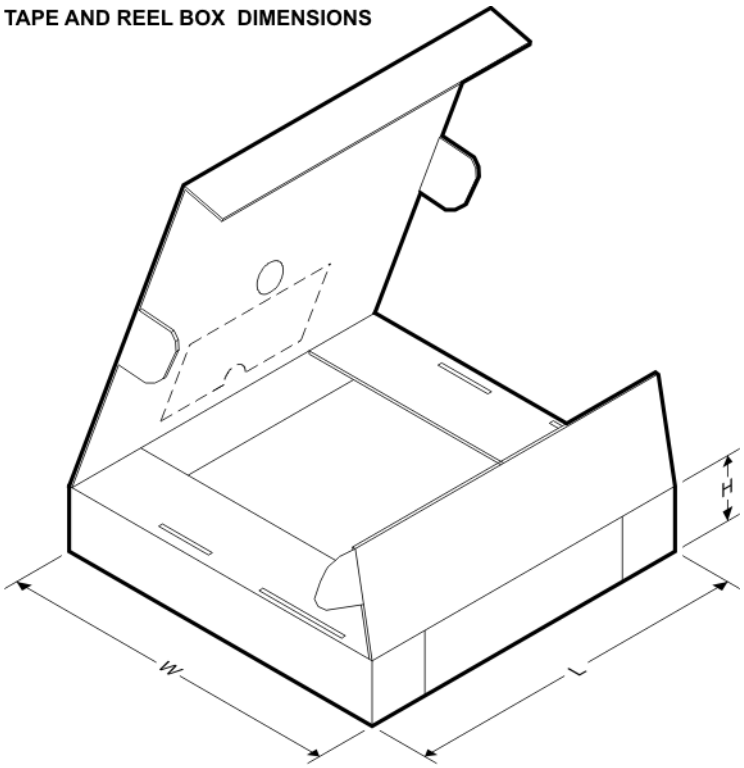
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
DS90CF384AQMTX/NOPB	TSSOP	DGG	56	1000	330.0	24.4	8.6	14.5	1.8	12.0	24.0	Q1

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

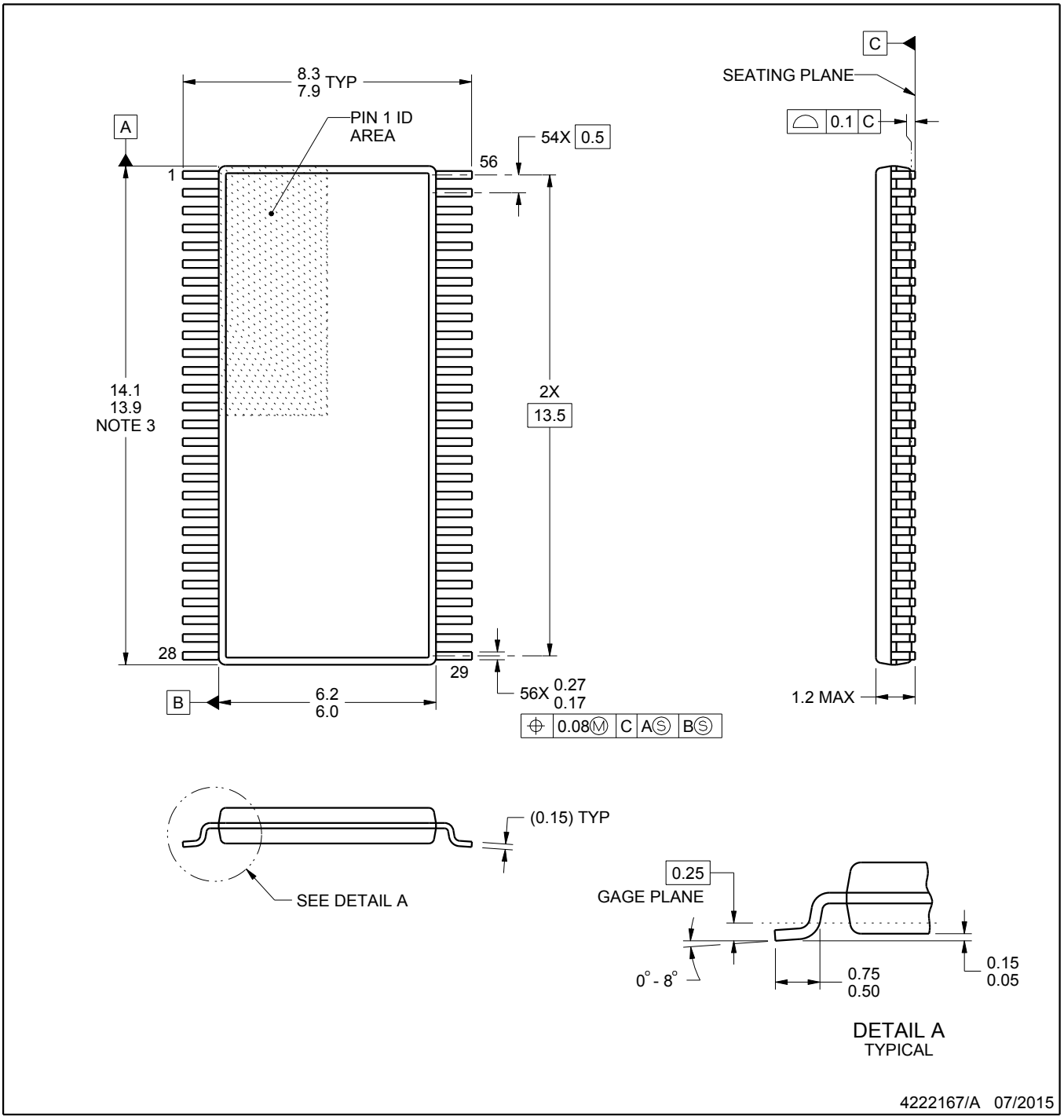
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
DS90CF384AQMTX/NOPB	TSSOP	DGG	56	1000	367.0	367.0	45.0

PACKAGE OUTLINE

DGG0056A

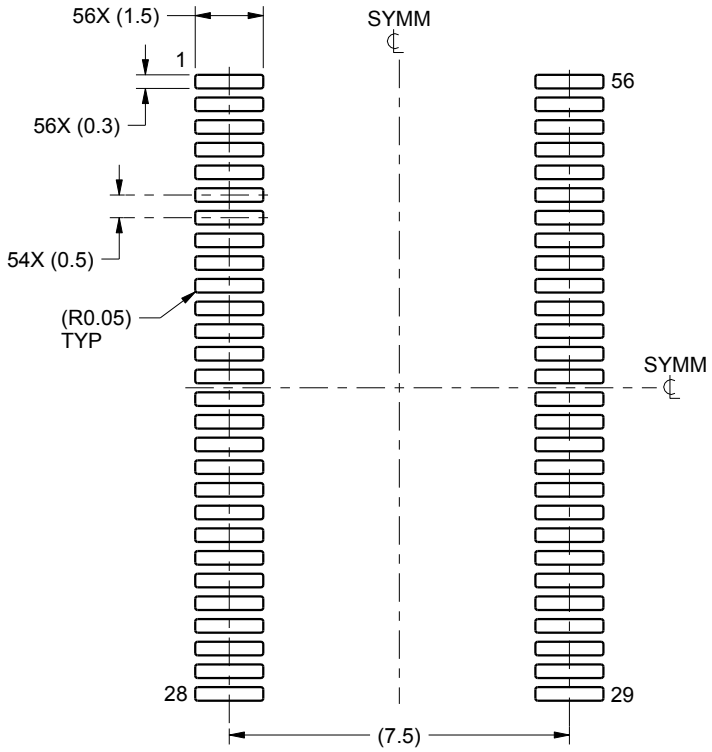
TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE

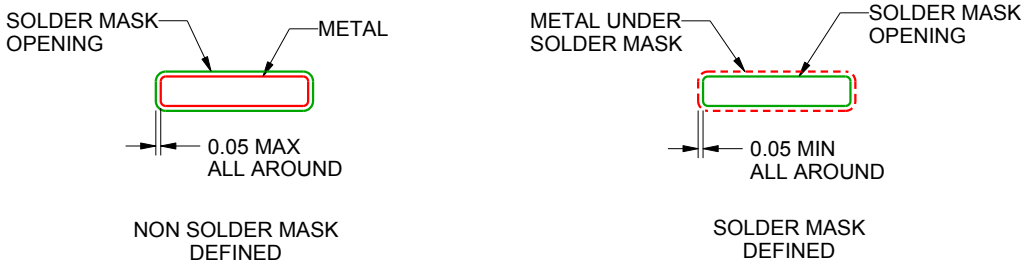


NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. Reference JEDEC registration MO-153.



LAND PATTERN EXAMPLE
SCALE:6X

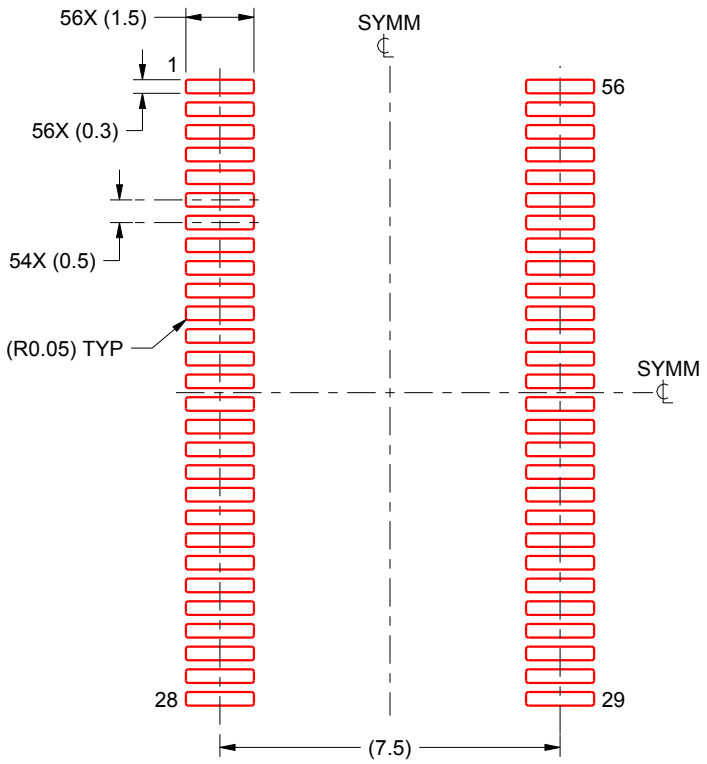


SOLDER MASK DETAILS

4222167/A 07/2015

NOTES: (continued)

5. Publication IPC-7351 may have alternate designs.
6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE:6X

4222167/A 07/2015

NOTES: (continued)

7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
8. Board assembly site may have different recommendations for stencil design.

IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATASHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES “AS IS” AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, or other requirements. These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify TI and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI’s products are provided subject to TI’s Terms of Sale (www.ti.com/legal/termsofsale.html) or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI’s provision of these resources does not expand or otherwise alter TI’s applicable warranties or warranty disclaimers for TI products.

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265